INFORMATION DISCLOSURE CITATION

(Use several sheets if necessary)

Docket Number (Optional)	Application Number
DE920020016US1	10/630957
Applicant(s) Appinger et al	
Filing Date 7/30/2003	Group Art Unit 2138

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U.S. PATENT DOCUMENTS

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U.S. PATENT APPLICATION PUBLICATIONS

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FOREIGN PATENT DOCUMENTS

	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation YES	NO

OTHER DOCUMENTS   *(Including Author, Title, Date, Pertinent Pages, Etc.)*

		"LFSR-Coded Test Patterns for Scan Designs" by B. Konemann, Pages 237-242
		"Decompression of Test Data Using Variable-Length Seed LFSRs" by J. Rajski et al, 1995 IEEE, Pages 426-433

EXAMINER	DATE CONSIDERED

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